IS41LV16100B



1M x 16 (16-MBIT) DYNAMIC RAM WITH EDO PAGE MODE

APRIL 2005

FEATURES

- TTL compatible inputs and outputs; tristate I/O
- · Refresh Interval:
 - Auto refresh Mode: 1,024 cycles /16 ms
 - RAS-Only, CAS-before-RAS (CBR), and Hidden
- · JEDEC standard pinout
- Single power supply: 3.3V ± 10%
- Byte Write and Byte Read operation via two CAS
- Industrial Temperature Range: -40°C to +85°C
- Lead-free available

DESCRIPTION

The ISSI IS41LV16100B is 1,048,576 x 16-bit high-performance CMOS Dynamic Random Access Memories. These devices offer an accelerated cycle access called EDO Page Mode. EDO Page Mode allows 1,024 random accesses within a single row with access cycle time as short as 20 ns per 16-bit word.

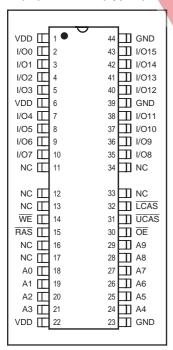
These features make the IS41LV16100B ideally suited for high-bandwidth graphics, digital signal processing, highperformance computing systems, and peripheral applications.

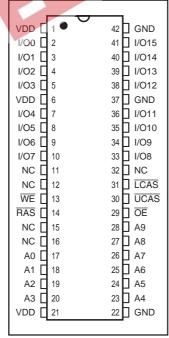
The IS41LV16100B is packaged in a 42-pin 400-mil SOJ and 400-mil 50- (44-) pin TSOP (Type II).

PIN CONFIGURATIONS

50(44)-Pin TSOP (Type II)

42-Pin SOJ





KEY TIMING PARAMETERS

| Parameter | -50 | -60 | Unit |
|---------------------------------------|-----|-----|------|
| Max. RAS Access Time (trac) | 50 | 60 | ns |
| Max. CAS Access Time (tcac) | 14 | 15 | ns |
| Max. Column Address Access Time (tAA) | 25 | 30 | ns |
| Min. EDO Page Mode Cycle Time (tpc) | 30 | 40 | ns |
| Min. Read/Write Cycle Time (trc) | 85 | 110 | ns |

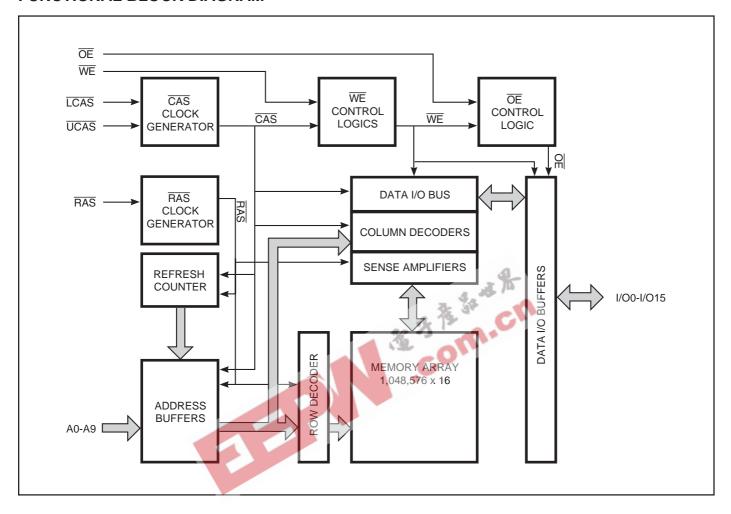
PIN DESCRIPTIONS

| A0-A9 | Address Inputs |
|---------|-----------------------------|
| I/O0-15 | Data Inputs/Outputs |
| WE | Write Enable |
| ŌĒ | Output Enable |
| RAS | Row Address Strobe |
| UCAS | Upper Column Address Strobe |
| LCAS | Lower Column Address Strobe |
| VDD | Power |
| GND | Ground |
| NC | No Connection |
| | <u> </u> |

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FUNCTIONAL BLOCK DIAGRAM



IS41LV16100B



TRUTH TABLE

| Function | | RAS | LCAS | UCAS | WE | ŌĒ | Address tr/tc | VO |
|-----------------------------------|------------------------|-------------------------------|-------------|------|-------------------|-----------|---------------|----------------------------------------|
| Standby | | Н | Н | Н | Х | Х | Х | High-Z |
| Read: Word | | L | L | L | Н | L | ROW/COL | Douт |
| Read: Lower Byte | | L | L | Н | Н | L | ROW/COL | Lower Byte, Douт Upper Byte, High-Z |
| Read: Upper Byte | | L | Н | L | Н | L | ROW/COL | Lower Byte, High-Z Upper Byte, Douт |
| Write: Word (Early Write) | | L | L | L | L | Х | ROW/COL | Din |
| Write: Lower Byte (Early | Write) | L | L | Н | L | Χ | ROW/COL | Lower Byte, DIN Upper Byte, High-Z |
| Write: Upper Byte (Early | Write) | L | Н | L | L | Χ | ROW/COL | Lower Byte, High-Z Upper Byte, DIN |
| Read-Write ^(1,2) | | L | L | L | H→L | L→H | ROW/COL | Dout, Din |
| EDO Page-Mode Read ⁽²⁾ | | L | H→L | H→L | Н | . 上下 | ROW/COL | Dоит |
| | 2nd Cycle: | L | H→L | H→L | H _e | L L | NA/COL | Dout |
| | Any Cycle: | L | L→H | | A H | L C | NA/NA | Dout |
| EDO Page-Mode Write(1) | | L | H→L | H→L | L | X | ROW/COL | DIN |
| | 2nd Cycle: | L | H→L | H→L | | X | NA/COL | DIN |
| EDO Page-Mode(1,2) | 1st Cycle: | | H→L | H→L | H→L | L→H | ROW/COL | Dout, Din |
| Read-Write | 2nd Cycle: | L | H→L | H→L | $H{ ightarrow} L$ | $L{\to}H$ | NA/COL | DOUT, DIN |
| Hidden Refresh | Read ⁽²⁾ | $L\rightarrow H\rightarrow L$ | L | L | Н | L | ROW/COL | Dout |
| | Write ^(1,3) | L→H→L | L | L | L | Χ | ROW/COL | Douт |
| RAS-Only Refresh | | L | Н | Н | Х | Х | ROW/NA | High-Z |
| CBR Refresh ⁽⁴⁾ | | H→L | L | L | Χ | Х | Χ | High-Z |

These WRITE cycles may also be BYTE WRITE cycles (either <u>LCAS</u> or <u>UCAS</u> active).
 These READ cycles may also be BYTE READ cycles (either <u>LCAS</u> or <u>UCAS</u> active).

^{3.} EARLY WRITE only.

^{4.} At least one of the two CAS signals must be active (LCAS or UCAS).



Functional Description

The IS41LV16100B is a CMOS DRAM optimized for high-speed bandwidth, low power applications. During READ or WRITE cycles, each bit is uniquely addressed through the 16 address bits. These are entered ten bits (A0-A9) at time. The row address is latched by the Row Address Strobe (RAS). The column address is latched by the Column Address Strobe (CAS). RAS is used to latch the first nine bits and CAS is used to latch the latter nine bits.

The IS41LV16100B has two $\overline{\text{CAS}}$ controls, $\overline{\text{LCAS}}$ and $\overline{\text{UCAS}}$. The $\overline{\text{LCAS}}$ and $\overline{\text{UCAS}}$ inputs internally generates a $\overline{\text{CAS}}$ signal functioning in an identical manner to the single $\overline{\text{CAS}}$ input on the other 1M x 16 DRAMs. The key difference is that each $\overline{\text{CAS}}$ controls its corresponding I/O tristate logic (in conjunction with $\overline{\text{OE}}$ and $\overline{\text{WE}}$ and $\overline{\text{RAS}}$). $\overline{\text{LCAS}}$ controls I/O0 through I/O7 and $\overline{\text{UCAS}}$ controls I/O8 through I/O15.

The IS41LV16100B CAS function is determined by the first CAS (LCAS or UCAS) transitioning LOW and the last transitioning back HIGH. The two CAS controls give the IS41LV16100B both BYTE READ and BYTE WRITE cycle capabilities.

Memory Cycle

A memory cycle is initiated by bring RAS LOW and it is terminated by returning both RAS and CAS HIGH. To ensures proper device operation and data integrity any memory cycle, once initiated, must not be ended or aborted before the minimum tras time has expired. A new cycle must not be initiated until the minimum precharge time trp, tcp has elapsed.

Read Cycle

A read cycle is initiated by the falling edge of $\overline{\text{CAS}}$ or $\overline{\text{OE}}$, whichever occurs last, while holding $\overline{\text{WE}}$ HIGH. The column address must be held for a minimum time specified by tar. Data Out becomes valid only when trac, taa, tcac and toea are all satisfied. As a result, the access time is dependent on the timing relationships between these parameters.

Write Cycle

A write cycle is initiated by the falling edge of $\overline{\text{CAS}}$ and $\overline{\text{WE}}$, whichever occurs last. The input data must be valid at or before the falling edge of $\overline{\text{CAS}}$ or $\overline{\text{WE}}$, whichever occurs first.

Auto Refresh Cycle

To retain data, 1,024 refresh cycles are required in each 16 ms period. There are two ways to refresh the memory.

- 1. By clocking each of the 1,024 row addresses (A0 through A9) with **RAS** at least once every 128 ms. Any read, write, readmodify-write or **RAS**-only cycle refreshes the addressed row.
- Using a CAS-before-RAS refresh cycle. CAS-before-RAS refresh is activated by the falling edge of RAS, while holding CAS LOW. In CAS-before-RAS refresh cycle, an internal 9-bit counter provides the row addresses and the external address inputs are ignored.

CAS-before-RAS is a refresh-only mode and no data access or device selection is allowed. Thus, the output remains in the High-Z state during the cycle.

Extended Data Out Page Mode

EDO page mode operation permits all 1,024 columns within a selected row to be randomly accessed at a high data rate.

In EDO page mode read cycle, the data-out is held to the next $\overline{\text{CAS}}$ cycle's falling edge, instead of the rising edge. For this reason, the valid data output time in EDO page mode is extended compared with the fast page mode. In the fast page mode, the valid data output time becomes shorter as the $\overline{\text{CAS}}$ cycle time becomes shorter. Therefore, in EDO page mode, the timing margin in read cycle is larger than that of the fast page mode even if the $\overline{\text{CAS}}$ cycle time becomes shorter.

 $\frac{\text{In EDO}}{\text{CAS}} \ \text{cycle time can be shorter than in the fast page mode} \\ \text{if the timing margin is the same}.$

The EDO page mode allows both read and write operations during one **RAS** cycle, but the performance is equivalent to that of the fast page mode in that case.

Power-On

After application of the VDD supply, an initial pause of 200 μ s is required followed by a minimum of eight initialization cycles (any combination of cycles containing a \overline{RAS} signal).

During power-on, it is recommended that **RAS** track with VDD or be held at a valid VIH to avoid current surges.



ABSOLUTE MAXIMUM RATINGS(1)

| Symbol | Parameters | | Rating | Unit |
|--------|------------------------------------|------|--------------|--------------|
| VT | Voltage on Any Pin Relative to GND | 3.3V | -0.5 to +4.6 | V |
| VDD | Supply Voltage | 3.3V | -0.5 to +4.6 | V |
| Іоит | Output Current | | 50 | mA |
| PD | Power Dissipation | | 1 | W |
| TA | Commercial Operation Temperature | | 0 to +70 | °C |
| | Industrial Operation Temperature | | -40 to +85 | $^{\circ}$ C |
| Тѕтс | Storage Temperature | | -55 to +125 | °C |

Note:

RECOMMENDED OPERATING CONDITIONS (Voltages are referenced to GND.)

| Symbol | Parameter | | Min. | Тур. | Max. | Unit |
|--------|--------------------------------|------|-----------------|------|-----------|------|
| VDD | Supply Voltage | 3.3V | 3.0 | 3.3 | 3.6 | V |
| VIH | Input High Voltage | 3.3V | 2.0 | _ | VDD + 0.3 | V |
| VIL | Input Low Voltage | 3.3V | -0.3 | _ | 0.8 | V |
| ТА | Commercial Ambient Temperature | | 0 | | 70 85 | °C |
| | Industrial Ambient Temperature | | -4 0 | _ | 85 | °C |

CAPACITANCE(1,2)

| Symbol | Parameter | Max. | Unit |
|--------|--------------------------------------------|------|------|
| CIN1 | Input Capacitance: A0-A9 | 5 | pF |
| CIN2 | Input Capacitance: RAS, UCAS, LCAS, WE, OE | 7 | pF |
| Сю | Data Input/Output Capacitance: I/O0-I/O15 | 7 | pF |

1. Tested initially and after any design or process changes that may affect these parameters.

2. Test conditions: TA = 25°C, f = 1 MHz.

^{1.} Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect /oltages ar reliability.



ELECTRICAL CHARACTERISTICS(1)

(Recommended Operating Conditions unless otherwise noted.)

| Symbol | Parameter | Test Condition | Speed | Min. | Max. | Unit |
|--------|----------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------|------|------------|----------|
| lıL | Input Leakage Current | Any input $0V \le V_{IN} \le V_{DD}$ Other inputs not under test = $0V$ | | -10 | 10 | μΑ |
| lio | Output Leakage Current | Output is disabled (Hi-Z) 0V ≤ Vouт ≤ Vpp | | -10 | 10 | μΑ |
| Vон | Output High Voltage Level | Iон = -2.0 mA (3.3V) | | 2.4 | _ | V |
| Vol | Output Low Voltage Level | IoL = 2.0 mA (3.3V) | | _ | 0.4 | V |
| lcc1 | Standby Current: TTL | RAS, LCAS, UCAS ≥ V _{IH} Commercial Industrial | 3.3V 3.3V | _ | 3 4 | mA mA |
| lcc2 | Standby Current: CMOS | $\overline{\text{RAS}}$, $\overline{\text{LCAS}}$, $\overline{\text{UCAS}} \ge V_{DD} - 0.2V$ | 3.3V | _ | 2 | mA |
| lcc3 | Operating Current: Random Read/Write ^(2,3,4) Average Power Supply Current | RAS, LCAS, UCAS, Address Cycling, tRc = tRc (min.) | -50 -60 | _ | 180 170 | mA |
| Icc4 | Operating Current: EDO Page Mode ^(2,3,4) Average Power Supply Current | RAS = VIL, LCAS, UCAS, Cycling tpc = tpc (min.) | -50 -60 | _ | 180 170 | mA |
| Icc5 | Refresh Current: RAS-Only ^(2,3) Average Power Supply Current | RAS Cycling, LCAS, UCAS ≥ VIH trc = trc (min.) | -50 -60 | _ | 180 170 | mA |
| Icc6 | Refresh Current: CBR ^(2,3,5) Average Power Supply Current | RAS, LCAS, UCAS Cycling trc = trc (min.) | -50 -60 | _ | 180 170 | mA |

Notes:

An initial pause of 200 μs is required after power-up followed by eight RAS refresh cycles (RAS-Only or CBR) before proper device operation is assured. The eight RAS cycles wake-up should be repeated any time the tREF refresh requirement is exceeded.

^{2.} Dependent on cycle rates.

^{3.} Specified values are obtained with minimum cycle time and the output open.

^{4.} Column-address is changed once each EDO page cycle.

^{5.} Enables on-chip refresh and address counters.



AC CHARACTERISTICS(1,2,3,4,5,6)

(Recommended Operating Conditions unless otherwise noted.)

| | | -4 | 50 | -(| -60 | | |
|---------------|--------------------------------------------------------------------|------|------|------|------|-------|--|
| Symbol trc | Parameter | Min. | Max. | Min. | Max. | Units | |
| | Random READ or WRITE Cycle Time | 85 | _ | 110 | _ | ns | |
| trac | Access Time from RAS(6, 7) | _ | 50 | _ | 60 | ns | |
| tcac | Access Time from CAS (6, 8, 15) | _ | 14 | _ | 15 | ns | |
| taa | Access Time from Column-Address ⁽⁶⁾ | _ | 25 | _ | 30 | ns | |
| tras | RAS Pulse Width | 50 | 10K | 60 | 10K | ns | |
| trp | RAS Precharge Time | 30 | _ | 40 | _ | ns | |
| tcas | CAS Pulse Width ⁽²⁶⁾ | 8 | 10K | 10 | 10K | ns | |
| tcp | CAS Precharge Time ^(9, 25) | 9 | _ | 10 | _ | ns | |
| tcsH | CAS Hold Time (21) | 50 | _ | 60 | _ | ns | |
| trcd | RAS to CAS Delay Time(10, 20) | 12 | 37 | 20 | 45 | ns | |
| tasr | Row-Address Setup Time | 0 | - | 0 | _ | ns | |
| t rah | Row-Address Hold Time | 8 | -0 | 10 | _ | ns | |
| tasc | Column-Address Setup Time(20) | 0 | 44. | 0 | _ | ns | |
| t CAH | Column-Address Hold Time(20) | 8 | _ | 10 | _ | ns | |
| tar | Column-Address Hold Time (referenced to RAS) | 30 | _ | 40 | _ | ns | |
| t rad | RAS to Column-Address Delay Time(11) | 14 | 25 | 15 | 30 | ns | |
| tral | Column-Address to RAS Lead Time | 25 | _ | 30 | _ | ns | |
| t RPC | RAS to CAS Precharge Time | 5 | _ | 5 | _ | ns | |
| trsh | RAS Hold Time ⁽²⁷⁾ | 14 | _ | 15 | _ | ns | |
| tclz | CAS to Output in Low-Z ^(15, 29) | 0 | _ | 0 | _ | ns | |
| tcrp | CAS to RAS Precharge Time(21) | 5 | _ | 5 | _ | ns | |
| top | Output Disable Time(19, 28, 29) | 3 | 12 | 3 | 12 | ns | |
| toe/toea | Output Enable Time(15, 16) | _ | 14 | _ | 15 | ns | |
| toehc | OE HIGH Hold Time from CAS HIGH | 15 | _ | 15 | _ | ns | |
| toep | OE HIGH Pulse Width | 10 | _ | 10 | _ | ns | |
| toes | OE LOW to CAS HIGH Setup Time | 5 | _ | 5 | _ | ns | |
| trcs | Read Command Setup Time(17,20) | 0 | _ | 0 | _ | ns | |
| t rrh | Read Command Hold Time (referenced to RAS) ⁽¹²⁾ | 0 | _ | 0 | _ | ns | |
| trch | Read Command Hold Time (referenced to CAS)(12, 17, 21) | 0 | _ | 0 | _ | ns | |
| twch | Write Command Hold Time(17,27) | 8 | _ | 10 | _ | ns | |
| twcr | Write Command Hold Time (referenced to RAS)(17) | 40 | _ | 50 | _ | ns | |



$\textbf{AC CHARACTERISTICS} \ (\texttt{Continued})^{(1,2,3,4,5,6)}$

(Recommended Operating Conditions unless otherwise noted.)

| | | | 50 | -(| | |
|---------------|------------------------------------------------------------------------------|------|-------|------|------|-------|
| Symbol | Parameter | Min. | Max. | Min. | Max. | Units |
| twp | Write Command Pulse Width(17) | 8 | _ | 10 | _ | ns |
| twpz | WE Pulse Widths to Disable Outputs | 10 | _ | 10 | _ | ns |
| trwL | Write Command to RAS Lead Time(17) | 13 | _ | 15 | _ | ns |
| tcwL | Write Command to CAS Lead Time(17,21) | 8 | _ | 15 | _ | ns |
| twcs | Write Command Setup Time(14, 17, 20) | 0 | _ | 0 | _ | ns |
| t DHR | Data-in Hold Time (referenced to RAS) | 39 | _ | 40 | _ | ns |
| toeh | OE Hold Time from WE during READ-MODIFY-WRITE cycle(18) | 14 | _ | 15 | _ | ns |
| tos | Data-In Setup Time(15, 22) | 0 | | 0 | _ | ns |
| ton | Data-In Hold Time ^(15, 22) | 8 | - 47 | 15 | _ | ns |
| trwc | READ-MODIFY-WRITE Cycle Time | 110 | * - N | 155 | _ | ns |
| trwd | READ-MODIFY-WRITE Cycle(14) | 65 | OM. | 85 | _ | ns |
| tcwd | CAS to WE Delay Time(14, 20) | 26 | _ | 40 | _ | ns |
| tawd | Column-Address to WE Delay Time(14) | 40 | _ | 55 | _ | ns |
| tpc | EDO Page Mode READ or WRITE Cycle Time ⁽²⁴⁾ | 30 | _ | 40 | _ | ns |
| t RASP | RAS Pulse Width in EDO Page Mode | 50 | 100K | 60 | 100K | ns |
| t CPA | Access Time from CAS Precharge(15) | _ | 30 | _ | 35 | ns |
| t PRWC | EDO Page Mode READ-WRITE Cycle Time ⁽²⁴⁾ | 56 | _ | 56 | _ | ns |
| tсон | Data Output Hold after CAS LOW | 5 | _ | 5 | _ | ns |
| toff | Output Buffer Turn-Off Delay from CAS or RAS (13,15,19,29) | 3 | 12 | 3 | 15 | ns |
| twnz | Output Disable Delay from WE | 3 | 10 | 3 | 15 | ns |
| tclch | Last CAS going LOW to First CAS returning HIGH ⁽²³⁾ | 10 | _ | 10 | _ | ns |
| tcsr | CAS Setup Time (CBR REFRESH)(30, 20) | 5 | _ | 5 | _ | ns |
| tchr | CAS Hold Time (CBR REFRESH)(30, 21) | 8 | _ | 10 | _ | ns |
| tord | OE Setup Time prior to RAS during HIDDEN REFRESH Cycle | 0 | _ | 0 | _ | ns |
| tref | Auto Refresh Period (1,024 Cycles) | _ | 16 | _ | 16 | ms |
| tτ | Transition Time (Rise or Fall)(2,3) | 3 | 50 | 3 | 50 | ns |



AC TEST CONDITIONS

Output load: One TTL Load and 50 pF ($VDD = 3.3V \pm 10\%$)

Input timing reference levels: $V_{IH} = 2.0V$, $V_{IL} = 0.8V$ ($V_{DD} = 3.3V \pm 10\%$)

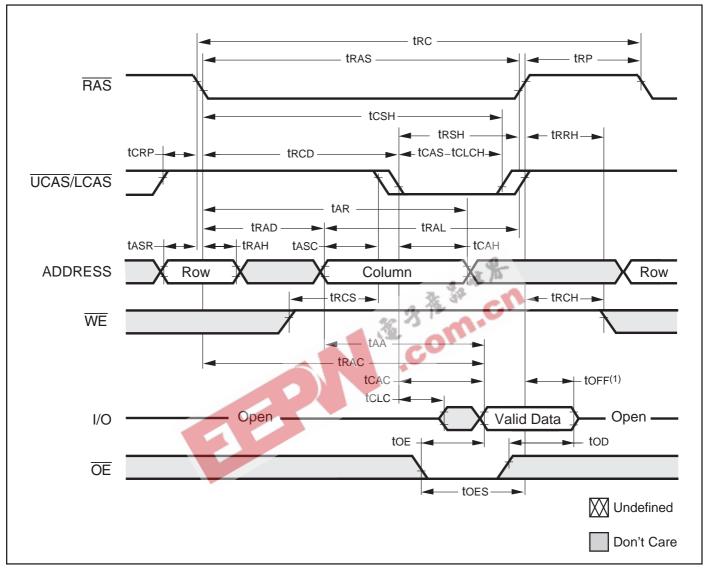
Output timing reference levels: VoH = 2.0V, VoL = 0.8V

Notes:

- 1. An initial pause of 200 µs is required after power-up followed by eight RAS refresh cycle (RAS-Only or CBR) before proper device operation is assured. The eight RAS cycles wake-up should be repeated any time the tref refresh requirement is exceeded.
- 2. VIH (MIN) and VIL (MAX) are reference levels for measuring timing of input signals. Transition times, are measured between VIH and VIL (or between VIL and VIH) and assume to be 1 ns for all inputs.
- 3. In addition to meeting the transition rate specification, all input signals must transit between V₁н and V₁∟ (or between V₁∟ and V₁н) in a monotonic manner.
- 4. If \overline{CAS} and $\overline{RAS} = V_{IH}$, data output is High-Z.
- 5. If CAS = VIL, data output may contain data from the last valid READ cycle
- 6. Measured with a load equivalent to one TTL gate and 50 pE
- 7. Assumes that tRCD ≤ tRCD (MAX). If tRCD is greater than the maximum recommended value shown in this table, tRAC will increase by the amount that tRCD exceeds the value shown.
- 8. Assumes that trcd ≤ trcd (MAX).
- 9. If CAS is LOW at the falling edge of RAS, data out will be maintained from the previous cycle. To initiate a new cycle and clear the data output buffer, CAS and RAS must be pulsed for tcp.
- 10. Operation with the tRCD (MAX) limit ensures that tRAC (MAX) can be met. tRCD (MAX) is specified as a reference point only; if tRCD is greater than the specified tRCD (MAX) limit, access time is controlled exclusively by tcac.
- 11. Operation within the trad (MAX) limit ensures that trcd (MAX) can be met. trad (MAX) is specified as a reference point only; if trad is greater than the specified trad (MAX) limit, access time is controlled exclusively by taa.
- 12. Either trich or trich must be satisfied for a READ cycle.
- 13. toff (MAX) defines the time at which the output achieves the open circuit condition; it is not a reference to Voh or Vol.
- 14. twcs, trwb, tawb and tcwb are restrictive operating parameters in LATE WRITE and READ-MODIFY-WRITE cycle only. If twcs ≤ twcs (MIN), the cycle is an EARLY WRITE cycle and the data output will remain open circuit throughout the entire cycle. If trwb ≤ trwb (MIN), tawp ≤ tawp (MIN) and tcwp ≤ tcwp (MIN), the cycle is a READ-WRITE cycle and the data output will contain data read from the selected cell. If neither of the above conditions is met, the state of I/O (at access time and until CAS and RAS or OE go back to V_{IH}) is indeterminate. \overline{OE} held HIGH and \overline{WE} taken LOW after \overline{CAS} goes LOW result in a LATE WRITE (\overline{OE} -controlled) cycle.
- 15. Output parameter (I/O) is referenced to corresponding CAS input, I/O0-I/O7 by CCAS and I/O8-I/O15 by UCAS.
- 16. During a READ cycle, if **OE** is LOW then taken HIGH before **CAS** goes HIGH, I/O goes open. If **OE** is tied permanently LOW, a LATE WRITE or READ-MODIFY-WRITE is not possible.
- 17. Write command is defined as WE going low.
- 18. LATE WRITE and READ-MODIFY-WRITE cycles must have both top and toen met (OE HIGH during WRITE cycle) in order to ensure that the output buffers will be open during the WRITE cycle. The I/Os will provide the previously written data if CAS remains LOW and **OE** is taken back to LOW after toeh is met.
- 19. The I/Os are in open during READ cycles once top or toff occur.
- 20. The first $\gamma \overline{CAS}$ edge to transition LOW.
- 21. The last χCAS edge to transition HIGH.
- 22. These parameters are referenced to CAS leading edge in EARLY WRITE cycles and WE leading edge in LATE WRITE or READ-MODIFY-WRITE cycles.
- 23. Last falling $\chi \overline{\text{CAS}}$ edge to first rising $\chi \overline{\text{CAS}}$ edge.
- 24. Last rising $\chi \overline{\text{CAS}}$ edge to next cycle's last rising $\chi \overline{\text{CAS}}$ edge.
- 25. Last rising $\chi \overline{\text{CAS}}$ edge to first falling $\chi \overline{\text{CAS}}$ edge.
- 26. Each χ**CAS** must meet minimum pulse width. 27. Last χ**CAS** to go LOW.
- 28. I/Os controlled, regardless UCAS and LCAS.
- 29. The 3 ns minimum is a parameter guaranteed by design.
- 30. Enables on-chip refresh and address counters.



READ CYCLE

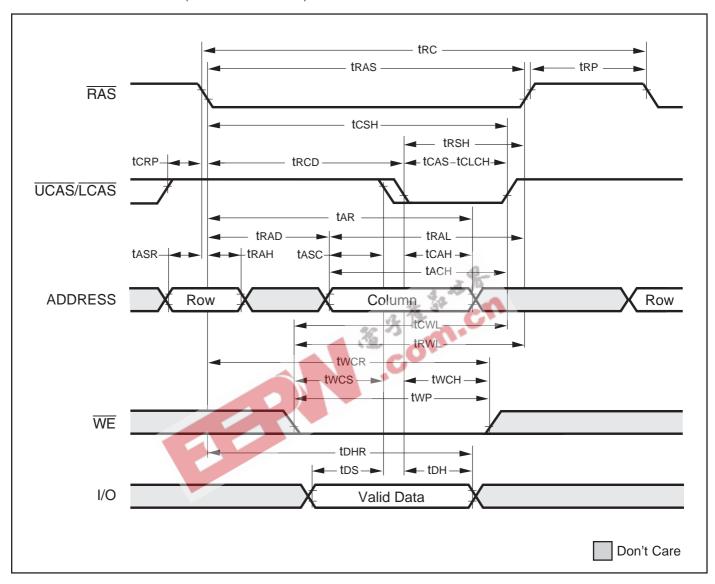


Note:

1. toff is referenced from rising edge of RAS or CAS, whichever occurs last.

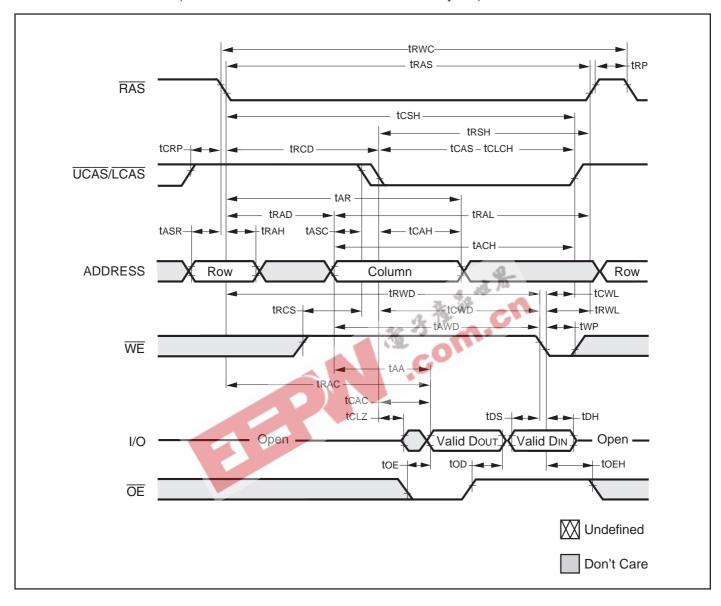


EARLY WRITE CYCLE (OE = DON'T CARE)



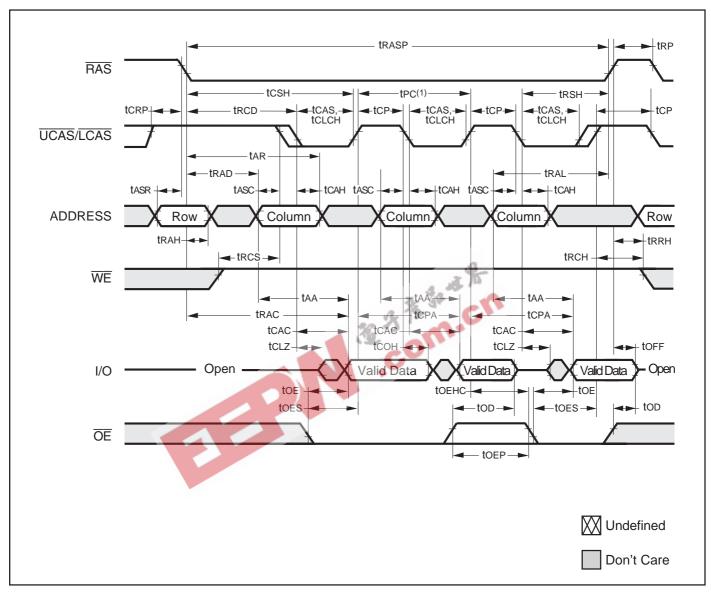


READ WRITE CYCLE (LATE WRITE and READ-MODIFY-WRITE Cycles)





EDO-PAGE-MODE READ CYCLE

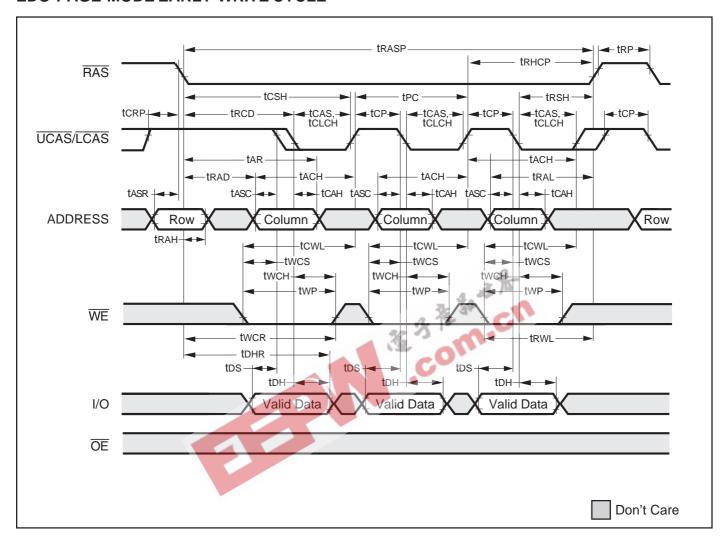


Note:

^{1.} tpc can be measured from falling edge of CAS to falling edge of CAS, or from rising edge of CAS to rising edge of CAS. Both measurements must meet the tpc specifications.

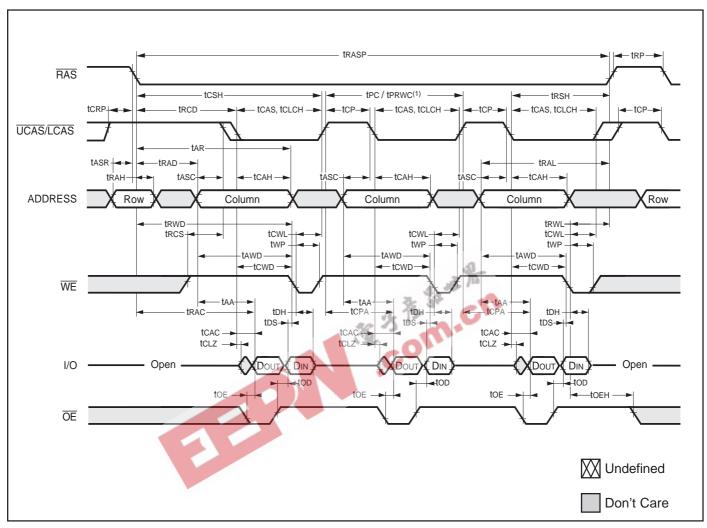


EDO-PAGE-MODE EARLY-WRITE CYCLE





EDO-PAGE-MODE READ-WRITE CYCLE (LATE WRITE and READ-MODIFY WRITE Cycles)

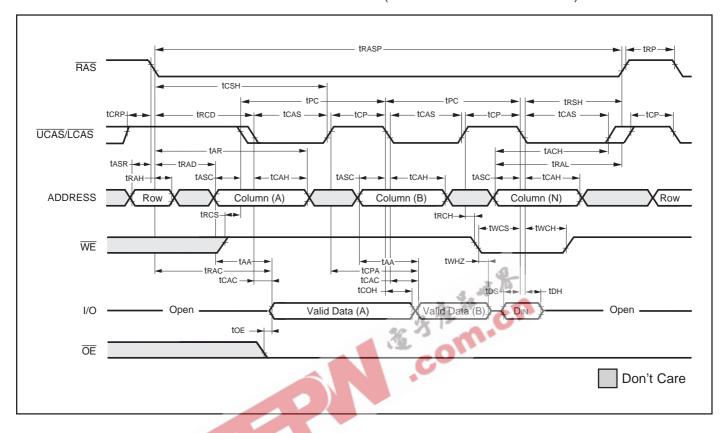


Note:

^{1.} tpc can be measured from falling edge of $\overline{\text{CAS}}$ to falling edge of $\overline{\text{CAS}}$, or from rising edge of $\overline{\text{CAS}}$ to rising edge of $\overline{\text{CAS}}$. Both measurements must meet the tpc specifications.



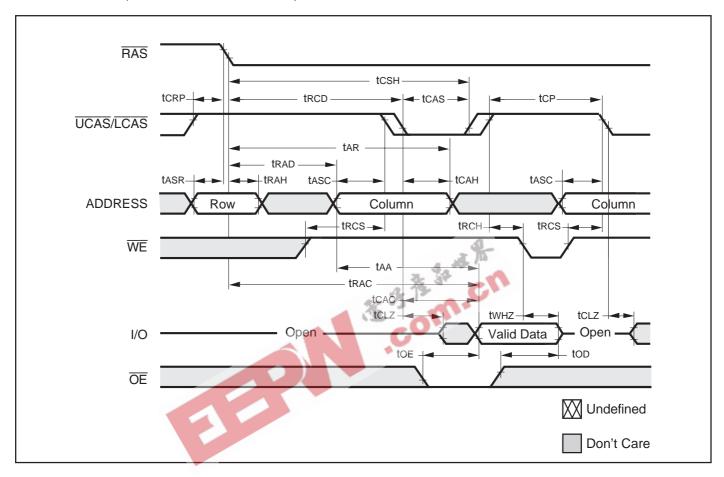
EDO-PAGE-MODE READ-EARLY-WRITE CYCLE (Pseudo READ-MODIFY WRITE)



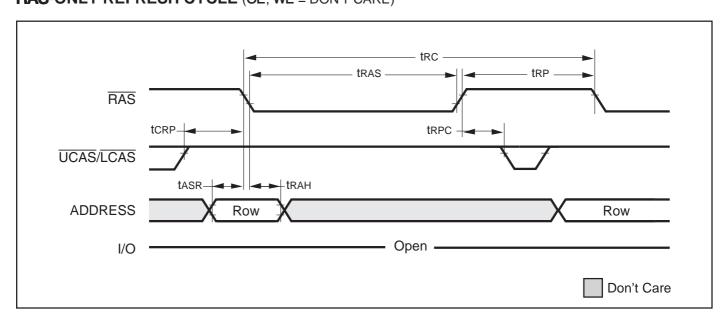


AC WAVEFORMS

$\textbf{READ CYCLE} \ (\textbf{With } \overline{\textbf{WE}}\text{-}\textbf{Controlled Disable})$

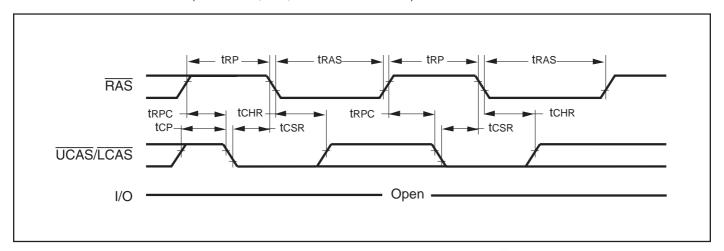


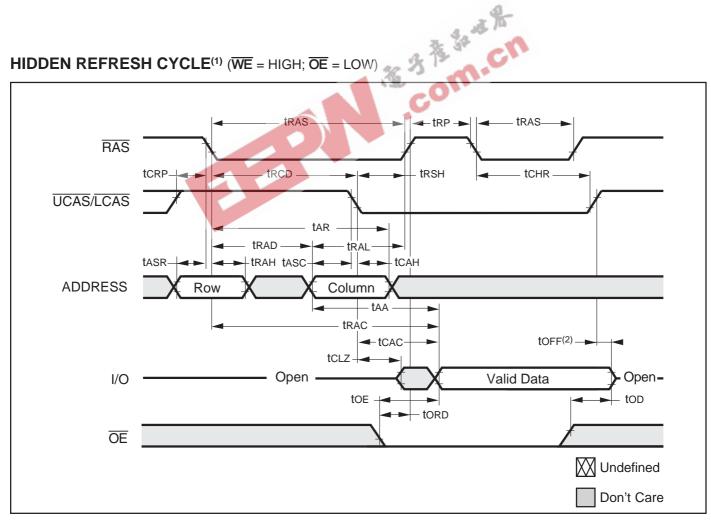
RAS-ONLY REFRESH CYCLE (OE, WE = DON'T CARE)





CBR REFRESH CYCLE (Addresses; WE, OE = DON'T CARE)





Notes:

- 1. A Hidden Refresh may also be performed after a Write Cycle. In this case, \overline{WE} = LOW and \overline{OE} = HIGH.
- 2. toff is referenced from rising edge of RAS or CAS, whichever occurs last.



ORDERING INFORMATION: 3.3V

Commercial Range: 0°C to +70°C

| Speed (ns) | Order Part No. | Package |
|------------|--------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------|
| 50 | IS41LV16100B-50K IS41LV16100B-50KL IS41LV16100B-50T IS41LV16100B-50TL | 400-mil SOJ 400-mil SOJ, Lead-free 400-mil TSOP (Type II) 400-mil TSOP (Type II), Lead-free |
| 60 | IS41LV16100B-60K IS41LV16100B-60KL IS41LV16100B-60T IS41LV16100B-60TL | 400-mil SOJ 400-mil SOJ, Lead-free 400-mil TSOP (Type II) 400-mil TSOP (Type II), Lead-free |

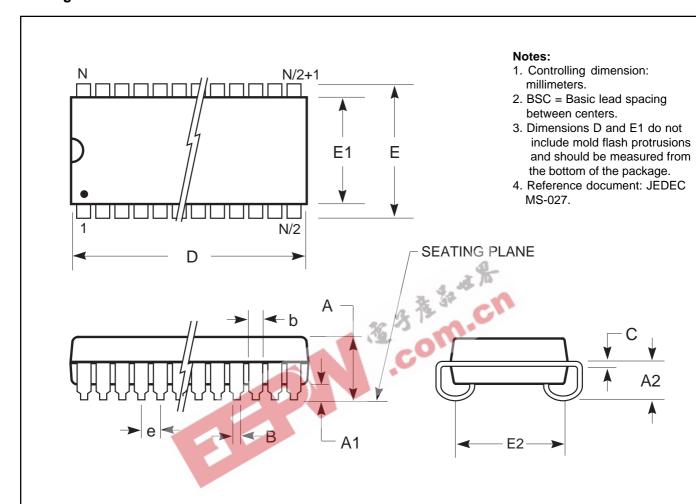
Industrial Range: -40°C to +85°C

| Industrial Rar | nge: -40°C to +85°C | 2 34 - 2 R |
|----------------|------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------|
| Speed (ns) | Order Part No. | Package |
| 50 | IS41LV16100B-50KI IS41LV16100B-50KLI IS41LV16100B-50TL IS41LV16100B-50TLI | 400-mil SOJ 400-mil SOJ, Lead-free 400-mil TSOP (Type II) 400-mil TSOP (Type II), Lead-free |
| 60 | IS41LV16100B-60KI IS41LV16100B-60KLI IS41LV16100B-60TI IS41LV16100B-60TLI | 400-mil SOJ 400-mil SOJ, Lead-free 400-mil TSOP (Type II) 400-mil TSOP (Type II), Lead-free |

PACKAGING INFORMATION



400-mil Plastic SOJ Package Code: K



| | Millim | eters | Inche | s | Millim | eters | Inche | es | Millin | neters | Inch | es |
|-----------|--------|-------|-------|-------|--------|-------|-------|-------|--------|--------|-------|-------|
| Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max |
| No. Leads | (N) | 28 | 3 | | | 3 | 2 | | | | 36 | |
| Α | 3.25 | 3.75 | 0.128 | 0.148 | 3.25 | 3.75 | 0.128 | 0.148 | 3.25 | 3.75 | 0.128 | 0.148 |
| A1 | 0.64 | _ | 0.025 | _ | 0.64 | _ | 0.025 | _ | 0.64 | _ | 0.025 | _ |
| A2 | 2.08 | _ | 0.082 | _ | 2.08 | _ | 0.082 | _ | 2.08 | _ | 0.082 | _ |
| В | 0.38 | 0.51 | 0.015 | 0.020 | 0.38 | 0.51 | 0.015 | 0.020 | 0.38 | 0.51 | 0.015 | 0.020 |
| b | 0.66 | 0.81 | 0.026 | 0.032 | 0.66 | 0.81 | 0.026 | 0.032 | 0.66 | 0.81 | 0.026 | 0.032 |
| С | 0.18 | 0.33 | 0.007 | 0.013 | 0.18 | 0.33 | 0.007 | 0.013 | 0.18 | 0.33 | 0.007 | 0.013 |
| D | 18.29 | 18.54 | 0.720 | 0.730 | 20.82 | 21.08 | 0.820 | 0.830 | 23.37 | 23.62 | 0.920 | 0.930 |
| Е | 11.05 | 11.30 | 0.435 | 0.445 | 11.05 | 11.30 | 0.435 | 0.445 | 11.05 | 11.30 | 0.435 | 0.445 |
| E1 | 10.03 | 10.29 | 0.395 | 0.405 | 10.03 | 10.29 | 0.395 | 0.405 | 10.03 | 10.29 | 0.395 | 0.405 |
| E2 | 9.40 | BSC | 0.370 | BSC | 9.40 | BSC | 0.370 |) BSC | 9.40 | BSC | 0.370 |) BSC |
| е | 1.27 | BSC | 0.050 |) BSC | 1.27 E | 3SC | 0.050 |) BSC | 1.27 | BSC | 0.050 |) BSC |

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| | Millimeters | | Inches | | Millim | Millimeters | | Inches | | Millimeters | | Inches | |
|-----------|-------------|-------|--------|-------|--------|-------------|-------|--------|-------|-------------|-------|--------|--|
| Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | |
| No. Leads | (N) | 4 | 0 | | | 42 | 2 | | | | 44 | | |
| A | 3.25 | 3.75 | 0.128 | 0.148 | 3.25 | 3.75 | 0.128 | 0.148 | 3.25 | 3.75 | 0.128 | 0.148 | |
| A1 | 0.64 | _ | 0.025 | _ | 0.64 | _ | 0.025 | _ | 0.64 | _ | 0.025 | _ | |
| A2 | 2.08 | _ | 0.082 | _ | 2.08 | _ | 0.082 | _ | 2.08 | _ | 0.082 | _ | |
| В | 0.38 | 0.51 | 0.015 | 0.020 | 0.38 | 0.51 | 0.015 | 0.020 | 0.38 | 0.51 | 0.015 | 0.020 | |
| b | 0.66 | 0.81 | 0.026 | 0.032 | 0.66 | 0.81 | 0.026 | 0.032 | 0.66 | 0.81 | 0.026 | 0.032 | |
| С | 0.18 | 0.33 | 0.007 | 0.013 | 0.18 | 0.33 | 0.007 | 0.013 | 0.18 | 0.33 | 0.007 | 0.013 | |
| D | 25.91 | 26.16 | 1.020 | 1.030 | 27.18 | 27.43 | 1.070 | 1.080 | 28.45 | 28.70 | 1.120 | 1.130 | |
| Е | 11.05 | 11.30 | 0.435 | 0.445 | 11.05 | 11.30 | 0.435 | 0.445 | 11.05 | 11.30 | 0.435 | 0.445 | |
| E1 | 10.03 | 10.29 | 0.395 | 0.405 | 10.03 | 10.29 | 0.395 | 0.405 | 10.03 | 10.29 | 0.395 | 0.405 | |
| E2 | 9.40 | BSC | 0.370 | BSC | 9.40 | BSC | 0.370 |) BSC | 9.40 | BSC | 0.370 | BSC | |
| е | 1.27 | BSC | 0.050 | BSC | 1.27 [| BSC | 0.050 | BSC | 1.27 | BSC | 0.050 | BSC | |



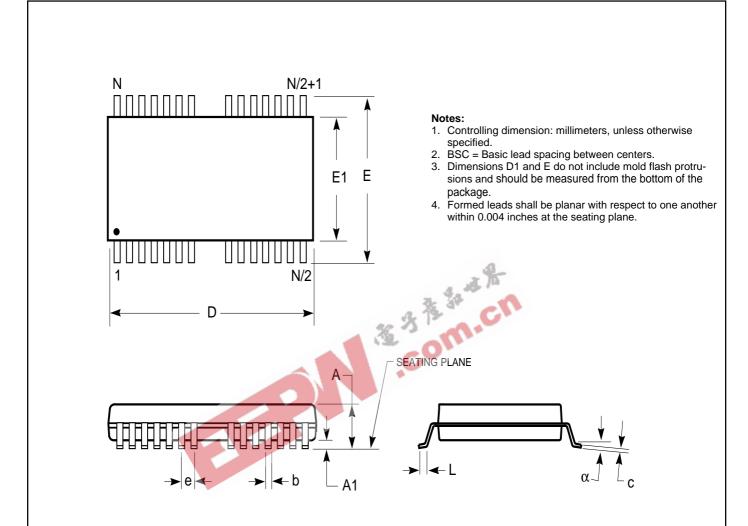
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PACKAGING INFORMATION



Plastic TSOP

Package Code: T (Type II)



| Plastic TSOP (T - Type II) (MS 25) | | | | | | |
|------------------------------------|----------|-------|-------|--------|--|--|
| | Millim | eters | Inch | es | | |
| Symbol | Min | Max | Min | Max | | |
| Ref. Std. | | | | | | |
| N | | 2 | 4/26 | | | |
| Α | | 1.20 | | 0.0472 | | |
| A1 | 0.05 | 0.15 | 0.002 | 0.0059 | | |
| b | 0.30 | 0.51 | 0.012 | 0.0201 | | |
| С | 0.12 | 0.21 | 0.005 | 0.0083 | | |
| D | 17.01 | 17.27 | 0.670 | 0.6899 | | |
| E ₁ | 7.49 | 7.75 | 0.295 | 0.3051 | | |
| е | 1.27 BSC | | 0.050 | BSC | | |
| Е | 9.02 | 9.42 | 0.462 | 0.4701 | | |
| L | 0.40 | 0.60 | 0.016 | 0.0236 | | |
| α | 0° | 5° | 0° | 5° | | |

| Plastic TSOP (T - Type II) (MS 24) | | | | | | |
|------------------------------------|--------|-------|-------|-----------|--|--|
| | Millim | eters | Incl | nes | | |
| Symbol | Min | Max | Min | Max | | |
| Ref. Std. | | | | | | |
| N | 40/44 | | | | | |
| Α | | 1.20 | | 0.0472 | | |
| A1 | 0.05 | 0.15 | 0.002 | 0.0059 | | |
| b | 0.30 | 0.45 | 0.012 | 0.0157 | | |
| С | 0.12 | 0.21 | 0.005 | 0.0083 | | |
| D | 18.31 | 18.51 | 0.721 | 0.7287 | | |
| E ₁ | 10.06 | 10.26 | 0.396 | 0.4040 | | |
| е | 0.80 | BSC | 0.03 | 0.031 BSC | | |
| E | 11.56 | 11.96 | 0.455 | 0.4709 | | |
| L | 0.40 | 0.60 | 0.016 | 0.0236 | | |
| α | 0° | 8° | 0° | 8° | | |
| | | | | | | |

| Plastic TSOP (T - Type II) (MS 24) | | | | | | |
|------------------------------------|--------|-------|--------|-----------|--|--|
| | Millim | eters | Inches | | | |
| Symbol | Min | Max | Min | Max | | |
| Ref. Std. | | | | | | |
| N | 44/50 | | | | | |
| Α | | 1.20 | | 0.0472 | | |
| A1 | 0.05 | 0.15 | 0.002 | 0.0059 | | |
| b | 0.30 | 0.45 | 0.012 | 0.0157 | | |
| С | 0.12 | 0.21 | 0.005 | 0.0083 | | |
| D | 20.85 | 21.05 | 0.821 | 0.8287 | | |
| E ₁ | 10.06 | 10.26 | 0.396 | 0.4040 | | |
| е | 0.80 | BSC | 0.03 | 0.031 BSC | | |
| Е | 11.56 | 11.96 | 0.455 | 0.4709 | | |
| L | 0.40 | 0.60 | 0.016 | 0.0236 | | |
| α | 0° | 8° | 0° | 8° | | |
| | | | | | | |